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TC7MTX01FK

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

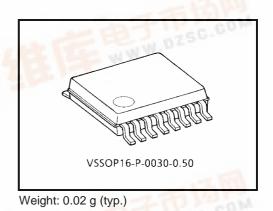
TC7MTX01FK

Digital temperature compensation IC

Due to the demand for compactness and lower power dissipation, circuits for portable devices are being manufactured as individual chips. In particular, during the manufacture of modular devices comprised of several individual discrete devices, significant time and effort must be devoted to adjusting the temperature characteristic of each discrete device individually, In addition, the demand for low power consumption is increasing.

In response to these requirements, Toshiba have developed the TC7MTX01FX, a digital temperature compensation IC.

Toshiba have implemented this device completely in CMOS, obviating the need to use combinations of individual electronic components, such as thermistors and resistors, as was the case previously. The new digital temperature compensation IC incorporates a temperature sensor, an E^2PROM and a DA converter. The IC is accurate to within $\pm 4^{\circ}$ C.



To meet the demand for compactness, the IC comes in the World's smallest and flattest 16-pin package (US16).

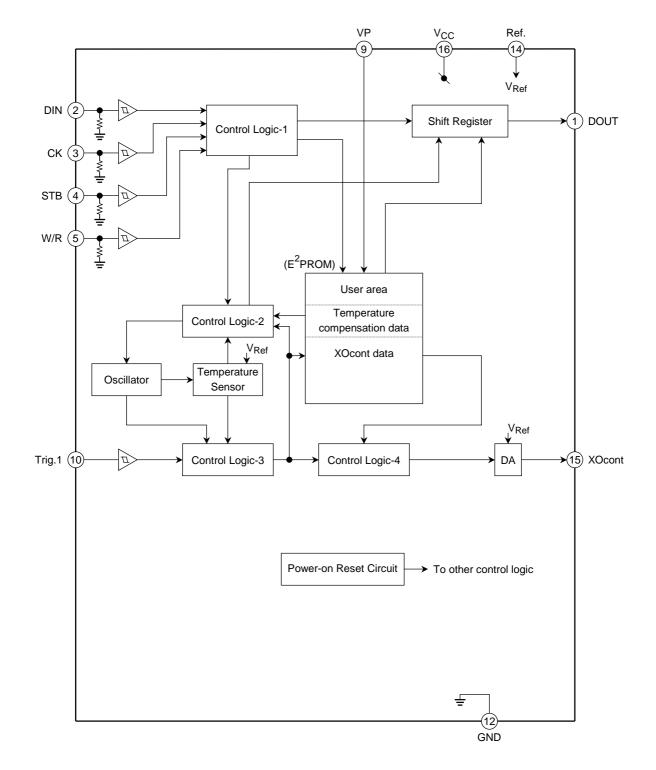
Features

Temperature compensation precision: $\pm 4^{\circ}C$ (in the range $-20 \sim 70^{\circ}C$) Pin Layout (top view) • Analog output (XOcont): DOUT 16 Vcc Outputs an analog voltage whose level corresponds to 1°C DIN 15 XOcont increments in the above temperature range. Control resolution: 10.98 mV (typ.)/Bit Ref. CK 14 Linearity: ±1LSB NC STB 13 Output response speed: 500 µs Supply voltage operating range: 2.7~3.3 V W/R 5 12 GND Built-in E²PROM : Write voltage 17 V (min)~19 V (max) Τ4 **T1** 6 11 : Write time: 10 ms Reference voltage (V_{Ref}): 2.8 V (typ.) T2 10 Trig.1 Current dissipation: 1.0 mA (max) @25°C V.P T₃ 8 ESD: ±2000 V or more (MIL-STD method) WWW.DZSC.COM Latch-up: ±200 mA or more

All pins (T1~T4) must be connected to the V_{CC} or the GND. Note:



Block Diagram



Pins 2~5 incorporate pull-down resistors (R \simeq 10 k Ω)

Description of Operation

Operation of E²PROM read/write OP codes

The operations listed below in the Operation mode selection table are performed using the five pins V.P, W/R, STB, CK and DIN.

All operations modes other than Normal Operation Mode are triggered by 8-bit serial data input on DIN and CK on the rising edge of STB. The operation mode is determined by the combination of the W/R signal and the OP code.

No.	Operating Mode	STB	\///D	W/R V.P		Serial input on DIN (CK)							
NO.		315	W/K		DI1	DI2	DI3	DI4	DI5	DI6	DI7	DI8	
1	E ² PROM write mode	Н	Н	18 V	Н	A6	A5	A4	A3	A2	A1	A0	
2	E ² PROM read mode	Н	L	_	Н	A6	A5	A4	A3	A2	A1	A0	
3	E ² PROM All-erase mode	Н	Н	18 V	L	Н	L	L	L	*	*	*	
4	E ² PROM All-write overwrite mode	Н	Н	18 V	L	Н	L	L	Н	*	*	*	
5	Temperature data read mode (before compensation: ADC output)	н	L		L	Н	L	Н	L	*	*	*	
6	Temperature data read mode (after compensation: register output)	н	L		L	Н	L	Н	Н	*	*	*	
7	Normal operation mode	L	L	_	*	*	*	*	*	*	*	*	

Operation	mode	selection	table
Operation	moue	SEIECLIUT	labie

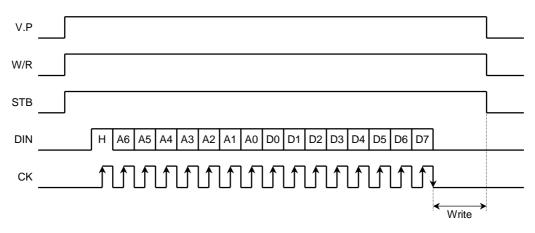
-: NC or V_{CC}, *: Don't care, A6~A0: specify address of E²PROM word

1. E^2 PROM Write Mode (V.P = 18 V, W/R = "H", DI1 = "H")

Input of an OP code (DI1 = H, A6~A0 = address of word to be written) on DIN (while 18 V is applied to V.P, W/R = H and STB = H) writes data D0~D7 to the E^2 PROM at the timing shown below.

Note that if D0~D7 are all High, a Byte Erase (all bits are set to H) is performed. The write starts on the falling edge of the 16th CK pulse and ends when STB goes Low.

During a write, DOUT is High-Impedance.

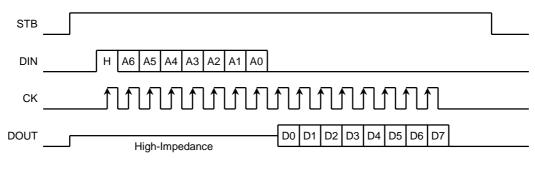


Data Write Mode timing chart

2. E²PROM Read Mode (W/R = "L", DI1 = "H")

Input of an OP code (DI1 = H, A6~A0 = address of word to be read) on DIN (while W/R = L and STB = H) reads data D0~D7 from the E²PROM to DOUT.

The read ends when STB goes Low.



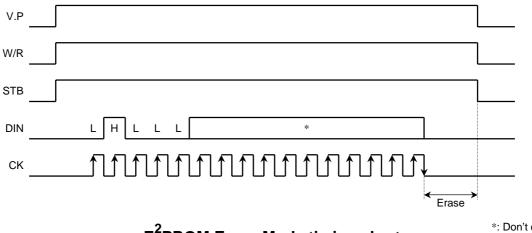
Data Read Mode timing chart

3. E²PROM All-erase Mode

(V.P = 18 V, W/R = "H", DI1 = "L", DI2 = "H", DI3 = "L", DI4 = "L", DI5 = "L")

Input of an OP code (DI1 = L, DI2 = H, DI3 = L, DI4 = L, DI5 = L) to DIN (while 18 V is applied to V.P, W/R = H and STB = H) proceeds to erase all data in the E2PROM (all bits are set to H), starting on the falling edge of the 16th CK pulse and continuing until STB goes Low.

During Erase Mode, DOUT is High-Impedance.



E²PROM Erase Mode timing chart

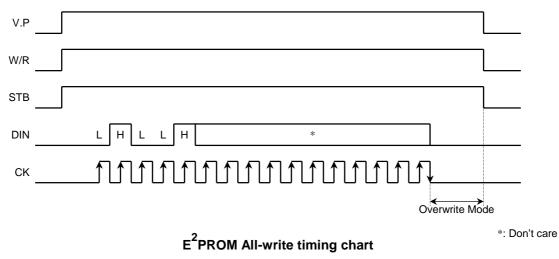
*: Don't care

4. E²PROM All-write Mode

(V.P = 18 V, W/R = "H", DI1 = "L", DI2 = "H", DI3 = "L", DI4 = "L", DI5 = "H")

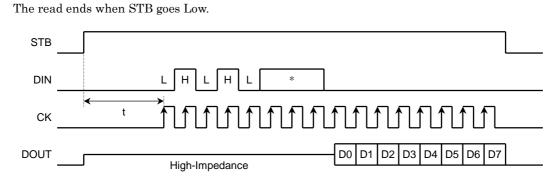
Input of an OP code (DI1 = L, DI2 = H, DI3 = L, DI4 = L, DI5 = H) on DIN (while 18 V is applied to V.P, W/R = H and STB = H) proceeds to overwrite the entire E²PROM (all bits are set to L), starting on the falling edge of the 16th CK pulse and continuing until STB goes Low.

During Overwrite Mode, DOUT is High-Impedance.



5. Temperature Data Read Mode (before compensation: temperature sensor output) (W/R = "L", DI1 = "L", DI2 = "H", DI3 = "L", DI4 = "H", DI5 = "L")

Input of an OP code (DI1 = L, DI2 = H, DI3 = L, DI4 = H, DI5 = L) on DIN converts the analog data from the temperature sensor to 8-bit digital data and outputs it on DOUT.



*: Don't care

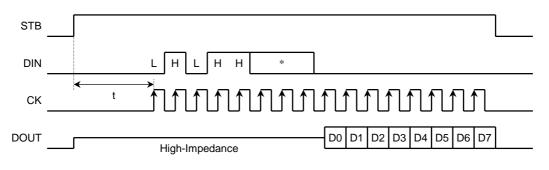
Timing chart for Temperature Data Read Mode (pre-compensation)

Note 1: The temperature sensor is triggered on the rising edge of STB. Allow a period of length t to elapse so that operation can stabilize.

6. Temperature Data Read Mode (after compensation: register output) (W/R = "L", DI1 = "L", DI2 = "H", DI3 = "L", DI4 = "H", DI5 = "H")

Input of an OP code (DI1 = L, DI2 = H, DI3 = L, DI4 = H, DI5 = H) on DIN outputs an 8-bit address on DOUT corresponding to the current temperature (sum of 8-bit temperature sensor output and 25° C temperature compensation data sensor stored at E²PROM address 0FH).

The read ends when STB goes Low.



*: Don't care Timing chart for Temperature Data Read Mode (post-compensation)

Note 1: The temperature sensor is triggered on the rising edge of STB. Allow a period of length t to elapse so that operation can stabilize.

7. Normal Operation Mode (STB = "L")

While STB = L, all inputs on W/R, CK and DIN are invalid and the IC is in Normal Operation Mode (this is referred to as XOcont Output Control state).

During Normal Operation Mode, the DOUT output level reflects the power-on reset status. (Output level is High during power-on reset and Low after release of power-on reset.)

E²PROM Contents

The E^2 PROM is organized as 8 bits x 124 words (= 992 bits) and its contents is as shown below.

14/	DIT			M/ and	DIT
Word (HEX)	BIT	Word (HEX)	BIT	Word (HEX)	BIT
	0 1 2 3 4 5 6 7		0 1 2 3 4 5 6 7	, ,	0 1 2 3 4 5 6 7
00	Reserved for users	30	XOcont (10°C)	60	XOcont (58°C)
01	As above	31	XOcont (11°C)	61	XOcont (59°C)
02	As above	32	XOcont (12°C)	62	XOcont (60°C)
03	As above	33	XOcont (13°C)	63	XOcont (61°C)
04	As above	34	XOcont (14°C)	64	XOcont (62°C)
05	As above	35	XOcont (15°C)	65	XOcont (63°C)
06	As above	36	XOcont (16°C)	66	XOcont (64°C)
07	As above	37	XOcont (17°C)	67	XOcont (65°C)
08	As above	38	XOcont (18°C)	68	XOcont (66°C)
09	As above	39	XOcont (19°C)	69	XOcont (67°C)
0A	As above	3A	XOcont (20°C)	6A	XOcont (68°C)
0B	As above	3B	XOcont (21°C)	6B	XOcont (69°C)
00	As above	3C	XOcont (22°C)	6C	XOcont (70°C)
0D	As above	3D	XOcont (23°C)	6D	XOcont (71°C)
0E	As above 25°C temperature sensor	3E	XOcont (24°C)	6E	XOcont (72°C)
0F	compensation data	3F	XOcont (25°C)	6F	XOcont (73°C)
10	XOcont (-22°C)	40	XOcont (26°C)	70	Reserved for users
11	XOcont (-21°C)	41	XOcont (27°C)	71	As above
12	XOcont (-20°C)	42	XOcont (28°C)	72	As above
13	XOcont (-19°C)	43	XOcont (29°C)	73	As above
14	XOcont (-18°C)	44	XOcont (30°C)	74	As above
15	XOcont (-17°C)	45	XOcont (31°C)	75	As above
16	XOcont (-16°C)	46	XOcont (32°C)	76	As above
17	XOcont (-15°C)	47	XOcont (33°C)	77	As above
18	XOcont (-14°C)	48	XOcont (34°C)	78	As above
19	XOcont (-13°C)	49	XOcont (35°C)	79	As above
1A	XOcont (-12°C)	4A	XOcont (36°C)	7A	As above
1B	XOcont (-11°C)	4B	XOcont (37°C)	7B	As above
1C	XOcont (-10°C)	4C	XOcont (38°C)		
1D	XOcont (-9°C)	4D	XOcont (39°C)		
1E	XOcont (-8°C)	4E	XOcont (40°C)		
1F	XOcont (-7°C)	4F	XOcont (41°C)		
20	XOcont (-6°C)	50	XOcont (42°C)		
21	XOcont (-5°C)	51	XOcont (43°C)		
22	XOcont (-4°C)	52	XOcont (44°C)		
23	XOcont (-3°C)	53	XOcont (45°C)		
24	XOcont (-2°C)	54	XOcont (46°C)		
25	XOcont (-1°C)	55	XOcont (47°C)		
26	XOcont (0°C)	56	XOcont (48°C)		
27	XOcont (1°C)	57	XOcont (49°C)		
28	XOcont (2°C)	58	XOcont (50°C)		
29	XOcont (3°C)	59	XOcont (51°C)		
2A	XOcont (4°C)	5A	XOcont (52°C)		
2B	XOcont (5°C)	5B	XOcont (53°C)		
2C	XOcont (6°C)	5C	XOcont (54°C)		
2D	XOcont (7°C)	5D	XOcont (55°C)		
2E	XOcont (8°C)	5E	XOcont (56°C)		
2F	XOcont (9°C)	5F	XOcont (57°C)		

E²PROM Data Save Map

(Contents of addresses 00H~0EH): Reserved area for users

(Contents of address 0FH): 25°C temperature sensor compensation data (8-bit data is used to compensate for temperature fluctuation in sensor ICs.)

(Contents of addresses 10H~6FH): XOcont temperature data (temperature range: -22°C~73°C, 8-bit data, one value for each 1°C increment) (Contents of addresses 70H~7BH): Reserved

XOcont Output Operation

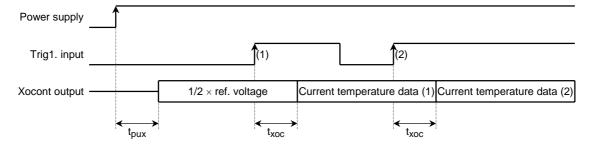
XOcont is the output pin used to output temperature compensation data (XOcont data) corresponding to the output from the built-in temperature sensor. Data corresponding to each 1° C temperature increment is stored in the E²PROM.

1. Output at power-on

At power-on, $1/2 \ge 1/2 \le 1/2$

2. Output caused by trigger input

The rising edge of the Trig.1 input triggers the built-in temperature sensor. The sum of the temperature sensor output and 25°C temperature sensor compensation data (stored at address 0FH) is used as the XOcont data address. The XOcont data is converted to an analog voltage level and output on XOcont. The delay time txoc, from Trig.1 input to start of voltage output, is 500 µs or less.



Output timing for XOcont

3. XOcont data

The XOcont data is stored at addresses 10H~6FH of the E²PROM and is used as compensation data corresponding to every 1°C increment in the ambient temperature range $-22^{\circ}C$ ~73°C.

The voltage output on XOcont corresponds to the 8-bit data stored in the E^2PROM (0 V for the value stored at address 00H; V_{Ref} for the value stored at address FFH).

When the ambient temperature is outside the range of the E²PROM table (i.e. below -22° C or above 73°C), the compensation value for the table's minimum or maximum temperature (-22° C or 73°C) is output.

Temperature Sensor

The IC incorporates a temperature sensor which can detect temperatures with an accuracy of 1°C. The sum of the output from the temperature sensor (after conversion to a digital value) and the 25°C temperature sensor compensation data (stored at address 0FH) is used as the E²PROM address of the compensation data.

In Normal Operation Mode, the temperature sensor is inactive. The sensor is triggered by the rising edge of STB or by the Trig.1 input. On completion of operation, the sensor returns to its inactive state.

The 25°C temperature sensor compensation data can be written to address 0FH of the E²PROM as follows:

1. Measurement of ambient temperature and device temperature data (before compensation)

- The ambient temperature of the test environment is measured.
- Read the temperature data of TC7MTX01FK before compensation

2. Calculation of 25°C temperature sensor compensation data

- If the ambient temperature is 25°C, the compensation data can be calculated as follows: 25°C temperature sensor compensation data = 3FH temperature data before compensation
- If the ambient temperature is not 25°C, add the difference between the ambient temperature and 25°C to the result of the above calculation.

The following table shows 25° C temperature sensor compensation values corresponding to the ambient temperature and the raw temperature data

Temperature Data			Am	bient Tempe	erature in Te	est Environm	ent		
before Compensation (TC7MTX01FK)	21°C	22°C	23°C	24°C	25°C	26°C	27°C	28°C	29°C
82		BA	BB	BC	BD	BE	BF	C0	C1
81	BA	BB	BC	BD	BE	BF	C0	C1	C2
80	BB	BC	BD	BE	BF	C0	C1	C2	C3
7F	BC	BD	BE	BF	C0	C1	C2	C3	C4
7E	BD	BE	BF	C0	C1	C2	C3	C4	C5
7D	BE	BF	C0	C1	C2	C3	C4	C5	C6
7C	BF	C0	C1	C2	C3	C4	C5	C6	C7
7B	C0	C1	C2	C3	C4	C5	C6	C7	C8
7A	C1	C2	C3	C4	C5	C6	C7	C8	C9
79	C2	C3	C4	C5	C6	C7	C8	C9	CA
78	C3	C4	C5	C6	C7	C8	C9	CA	CB
77	C4	C5	C6	C7	C8	C9	CA	СВ	CC
76	C5	C6	C7	C8	C9	CA	СВ	CC	CD
75	C6	C7	C8	C9	CA	CB	CC	CD	CE
74	C7	C8	C9	CA	СВ	CC	CD	CE	CF
73	C8	C9	CA	СВ	CC	CD	CE	CF	D0
72	C9	CA	СВ	CC	CD	CE	CF	D0	D1
71	CA	CB	CC	CD	CE	CF	D0	D1	D2
70	СВ	CC	CD	CE	CF	D0	D1	D2	D3
6F	CC	CD	CE	CF	D0	D1	D2	D3	D4
6E	CD	CE	CF	D0	D1	D2	D3	D4	D5
6D	CE	CF	D0	D1	D2	D3	D4	D5	D6
6C	CF	D0	D1	D2	D3	D4	D5	D6	D7
6B	D0	D1	D2	D3	D4	D5	D6	D7	D8
6A	D1	D2	D3	D4	D5	D6	D7	D8	D9
69	D2	D3	D4	D5	D6	D7	D8	D9	

25°C temperature sensor compensation values corresponding to the ambient temperature and the temperature data before compensation

All values above are hexadecimal.

3. E²PROM Write

This instruction writes the 25° C address compensation data to address 0FH in the E²PROM.

Maximum Ratings (GND = 0.0 V)

Characteristic	Symbol	Rating	Unit	Pin
Supply voltage	V _{CC}	-0.5~4.6	V	V _{CC}
E ² PROM write voltage	VP	-0.5~20.0	V	V.P
Reference voltage	V _{Ref}	$-0.5 \sim V_{CC} + 0.5$	V	Ref.
Input voltage	V _{IN}	-0.5~4.0	V	DIN, CK, STB, W/R, Trig1
Output voltage	Vout	$-0.5 \sim V_{CC} + 0.5$	V	DOUT, XOcont
Input current	I _{IN}	±10	mA	DIN, CK, STB, W/R, Trig1
Power dissipation	PD	180	mW	
Storage temperature	T _{stg}	-40~125	°C	

Recommended Operating Conditions (GND = 0.0 V)

Characteristic	Symbol	Min	Тур.	Max	Unit
Supply voltage	V _{CC}	2.7	3.0	3.3	V
E ² PROM write voltage	VP	17.0	18.0	19.0	V
Reference voltage	V _{Ref}	2.7	2.8	2.9	V
Input voltage	V _{IN}	0	_	V _{CC}	V
Input rise/fall time	t _{rþ} , t _{fþ}	_	_	1.0	μS
Power-on rise time	t _v	100	_	_	μS
Operating temperature	T _{opr}	-22		73	°C

E²PROM Characteristics

Characteristic	Symbol	Test Circuit	Min	Тур.	Max	Unit
No. of rewrites	N _{wr}	Ta = 25°C, V _{CC} = 3.0 V, V _P = 18.0 V	10000			Times
Data retention time	t _{RET}	Ta = -22~73°C	10	_	_	Years

Characteristic	Symbol	Test Circuit	Ta =	-20°C	-	Ta = 25°0	2	Ta =	Unit	
Characteristic	Symbol	Test Circuit	Min	Max	Min	Тур.	Min	Min	Max	Unit
High-level input voltage	VIH	$V_{CC} = 2.7 \sim 3.3 \text{ V}$	2.0	_	2.0		_	2.0		V
Low-level input voltage	VIL	$V_{CC} = 2.7 \sim 3.3 \text{ V}$	_	0.5	_	_	0.5	_	0.5	V
Hysteresis voltage	V _H	$V_{CC} = 3.0V$				0.3	—			V
High-level output current (DOUT)	I _{ОН}	$\begin{array}{l} V_{CC}=3.0 \ V \\ V_{OH}=2.4 \ V \end{array}$	4.0		4.0	7.0	_	3.2	_	mA
Low-level output current (DOUT)	I _{OL}	$\begin{array}{l} V_{CC}=3.0 \ V \\ V_{OL}=0.4 \ V \end{array}$	4.0	_	4.0	8.5	_	3.2	_	mA
Input current	I _{IN}	V _{CC} = 3.3 V V _{IN} = 0 or 3.3 V	_	±1.0	_	_	±1.0	_	±5.0	μA
Three-state OFF leakage current (DOUT)	I _{OZ}	V _{CC} = 3.3 V V _{OUT} = 0 or 3.3 V	_	±1.0	_	_	±1.0		±5.0	μA
Pull-down resistance (DIN, CK, STB, W/R)	R _{PD}	V _{CC} = 2.7~3.3 V	_	_	4	10	20	_	_	kΩ
Auto-reset release voltage	V _{RD}		_	2.5	_	1.8	2.5	_	2.5	V
Static current dissipation	Icc	$V_{CC} = 3.0 \text{ V} \text{ (Note 2)}$ $V_{IN} = V_{CC} \text{ or GND}$		_	_	0.5	1.0	_	_	mA
Static current dissipation	I _{REF}	$\begin{array}{l} V_{CC} = 2.8 \ V (Note2) \\ V_{IN} = V_{CC} \ or \ GND \end{array}$			_	0.1	1.0		_	mA

Note2: The current generated by setting the input pins with pull-down resistors to High is not included.

AC Characteristics (Ta = 25°C, V_{CC} = 3.0 V, V_{Ref} = 2.8 V, GND = 0 V, C_L = 50 pF, Input: t_r, t_f = 6 ns)

E²PROM Write Timing (applies to Operation Modes 1, 3 and 4)

Characteristic	Symbol	Test Circuit	Тур	Limit	Unit
Minimum VP power-on timing time (V.P power supply – STB input)	t _{sv}	Figure 1	_	0	ns
Minimum VP power-off timing time (STB input – V.P power supply)	t _{hv}	Figure 1	_	0	ns
Minimum VP power supply cut-off pulse width	t _{wL}	Figure 1	_	10	μS
Minimum set-up time (W/R input – STB input)	t _{sw}	Figure 1	_	0	ns
Minimum hold time (W/R input – STB input)	t _{hw}	Figure 1	_	40	ns
Minimum removal time (STB input – CK input)	t _{rem}	Figure 1	-5	40	ns
Minimum write time (CK input – W/R input)	t _{pws}	Figure 1	_	10	ms
Minimum pulse width (STB input)	t _{wL}	Figure 1	_	10	μS
Minimum clock cycle time (CK input)	t _{cyc}	Figure 1	0.2	2	μS
Minimum clock pulse width (CK input)	t _{wH} t _{wL}	Figure 1	0.1	1	μS
Minimum set-up time (DIN input – CK input)	t _{su}	Figure 1	-3	40	ns
Minimum hold time (DIN input – CK input)	t _h	Figure 1	5	40	ns

E²PROM Read Timing (applies to Operation Mode 2)

Characteristic	Symbol	Test Circuit	Тур	Limit	Unit
Minimum set-up time (W/R input – STB input)	t _{sr}	Figure 2	_	0	ns
Minimum hold time (W/R input – STB input)	t _{hr}	Figure 2	_	0	ns
Minimum removal time (STB input – CK input)	t _{rem}	Figure 2	-5	40	ns
Minimum pulse width (STB input)	t _{wL}	Figure 2	0.1	1	μS
Minimum clock cycle time (CK input)	t _{cyc}	Figure 2	0.2	2	μS
Minimum clock pulse width (CK input)	t _{wH} t _{wL}	Figure 2	0.1	1	μS
Minimum set-up time (DIN input – CK input)	t _{su}	Figure 2	-3	40	ns
Minimum hold time (DIN input – CK input)	t _h	Figure 2	5	40	ns
Propagation delay time (CK input – DOUT output)	t _{pZH} t _{pZL}	On first DOUT output Figure 2	15	100	ns
Propagation delay time (CK input – DOUT output)	t _{pLH} t _{pHL}	On second and subsequent DOUT outputs Figure 2	15	100	ns
Output Disable time (STB input – DOUT output)	t _{PLZ} t _{pHL}	Figure 2	20	100	ns

Timing in Other Modes (applies to Operation Modes 5 and 6)

Characteristic	Symbol	Test Circuit	Тур	Limit	Unit
Minimum removal time (STB input – CK input)	t _{rem}	Operation modes 5 and 6 (temperature data read modes) Figure 2	140	400	μS

Note3: All characteristics except for t_{rem} are the same as those for the E²PROM read timing.

Characteristics of Analog Block (Ta = 25° C, V_{CC} = 2.80 V, V_{Ref} = 2.80 V, GND = 0 V)

XOcont Output

Characteristic	Symbol	Test Circuit	Ta = 25°C			Ta = -20~70°C		Unit
			Min	Тур.	Max	Min	Max	Unit
XOcont output response time (Trig.1 – XOcont)	t _{xoc}	Figure 3	_	200	450	_	500	μS
XOcont output voltage	V _{XOC}	XOcont data: 80H XOcont output < 1 μA	1380	1400	1420	1380	1420	mV
XOcont output voltage variation	ΔV _{XOC}	XOcont data1 per bit XOcont output < 1 μA	_	10.98		_		mV
XOcont output voltage linearity	ANLX	XOcont data: $00H \le DATA \le FFH$ (Note 4)	_	±0.5	±1	_	±1	LSB

Temperature Sensor

Characteristic	Symbol	Test Circuit		Тур.	Max	Unit
Temperature sensor output Value (output at Ta = 25°C before compensation)	Tsen1	Ta = 25°C Temperature sensor output before compensation	60H	74H	88H	_
Temperature sensor output Value (output at Ta = -22°C before compensation)	Tsen2	Ta = -22°C Temperature sensor output before compensation	31H	45H	59H	_
Temperature sensor output Value (output at Ta = 72°C before compensation)	Tsen3	Ta = 73°C Temperature sensor output before compensation	90H	A4H	B8H	_
Temperature sensor output Variation	ΔTS	Per 1°C		1		LSB
Temperature sensor output Linearity	ΔNLT	$-22^{\circ}C \le Ta \le 73^{\circ}C$ (Note4) —	±0.5	±4	LSB

Note 4: The linearity is the deviation of the actual characteristic curve from the expected variation.

TC7MTX01FK

Timing Charts

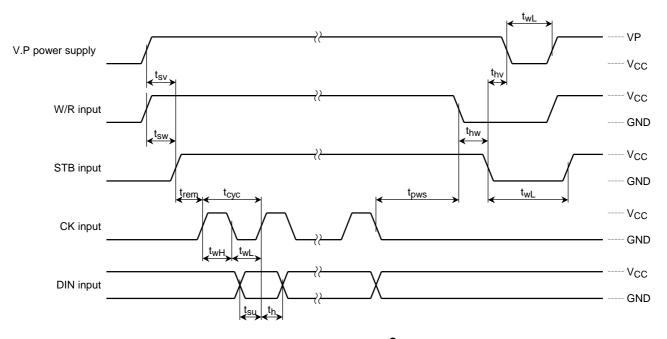
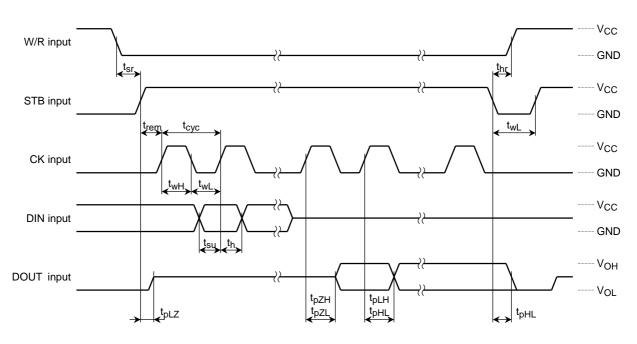
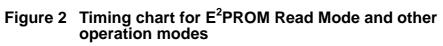


Figure 1 Timing chart for E²PROM Write Mode





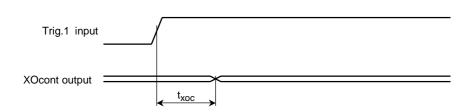
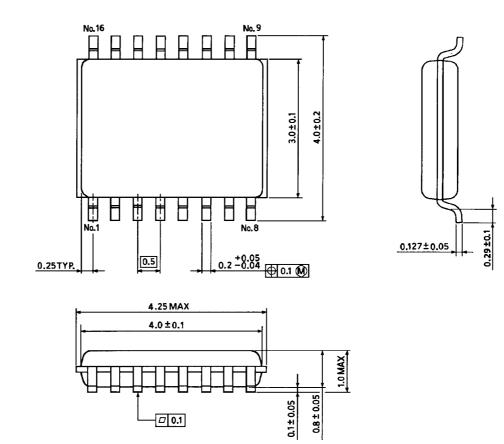


Figure 3 Timing chart for analog output

Package Dimensions

VSSOP16-P-0030-0.50

Unit : mm



Weight: 0.02 g (typ.)

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000707EBA

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